


<b>Search Notes</b>  	<b>Application/Control No.</b>  10064620	<b>Applicant(s)/Patent Under Reexamination</b>  MUKHOPADHYAY ET AL.
	<b>Examiner</b>  Hung, Yubin	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	131, 154, 232-253	5/10/07	YH
345	419, 420, 424	5/10/07	YH
348	390.1	5/10/07	YH
375	240	5/10/07	YH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	05/11/07	YH
SPIE	05/11/07	YH
IEEE Xplore	05/11/07	YH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner